



SPECIFICATION

SPEC. No. _____

DATE : _____

Customer

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME

MULTILAYER CERAMIC CHIP CAPACITORS
C1005, C1608, C2012, C3216, C3225, C4532,
C5750 Type / 100V to 630V
C0G, X7R, X7S, X7T Characteristics

Please sign and return this specification to your local TDK representatives. If orders are placed without this returned documentation, we must consider you found the specification acceptable.

THIS SPECIFICATION IS RECEIVED

DATE: _____ YEAR _____ MONTH _____ DAY _____

TDK-EPC Corporation
1-13-1, Nihonbashi, Chuo-ku, Tokyo
103-0027, Japan

ENGINEERING

ISSUED	CHECKED	APPROVED
DATE	DATE	DATE

Sales Office _____

Sales Tel. _____ () _____

PRODUCT CLASSIFICATION
CODE

040320

1. SCOPE

This specification is applicable to chip type multilayer ceramic capacitors with a priority over other relevant specifications. Production places defined in this specification shall be TDK-EPC Corporation Japan, TDK (Suzhou) Co., Ltd, TDK-EPC HONG KONG LIMITED, TDK (Malaysia) Sdn. Bhd, and TDK Components U.S.A. Inc.

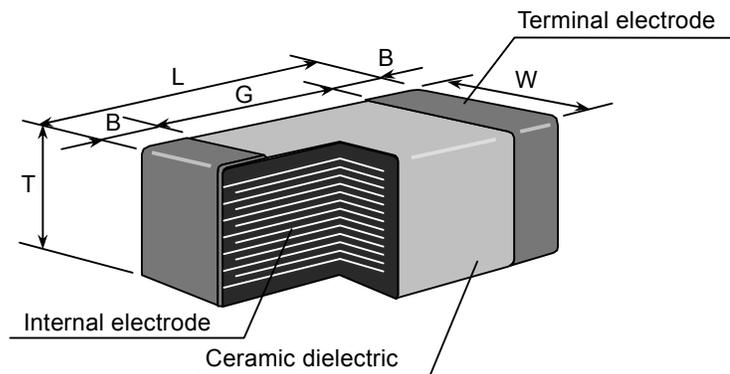
EXPLANATORY NOTE:

This specification warrants the quality of the TDK ceramic chip capacitors. The product should be evaluated and confirmed in your product before use. If the use of the product exceeds the bounds of this specification, we can not guarantee its quality and reliability.

2. CODE CONSTRUCTION

(Example) C2012 X7R 2E 472 M T
 (1) (2) (3) (4) (5) (6)

(1) Type



Please refer to product list for the dimension of each product. See Section 9 for inside structure and material.

(2) Temperature Characteristics (Details are shown in Section 8, No.7 and No.8)

(3) Rated Voltage

Symbol	Rated Voltage
2 J	DC 630 V
2 W	DC 450 V
2 E	DC 250 V
2 A	DC 100 V

(4) Rated Capacitance

Stated in three digits and in units of pico farads (pF). The first and second digits identify the first and second significant figures of the capacitance: the third digit identifies the multiplier.

R is designated for a decimal point.

Example 472 → 4,700pF

(5) Capacitance tolerance

Symbol	Tolerance
J	$\pm 5\%$
K	$\pm 10\%$
M	$\pm 20\%$

(6) Packaging

Symbol	Packaging
B	Bulk
T	Taping

3. RATED CAPACITANCE AND CAPACITANCE TOLERANCE

1. Standard combination of rated capacitance and tolerances

Class	Temperature Characteristics	Capacitance tolerance		Rated capacitance
1	C0G	10,000pF and under	J ($\pm 5\%$)	E – 12 series
		Over 10,000pF	K ($\pm 10\%$)	E – 6 series
2	X7R X7S X7T	K ($\pm 10\%$) M ($\pm 20\%$)		E – 6 series

2. Capacitance Step in E series

E series	Capacitance Step											
E- 6	1.0	1.5	2.2	3.3	4.7	6.8						
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2

4. OPERATING TEMPERATURE RANGE

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
C0G, X7R, X7S, X7T	-55°C	125°C	25°C

5. STORING CONDITION AND TERM

5 to 40°C at 20 to 70%RH

6 months Max.

6. P.C. BOARD

When mounting on an aluminum substrate, large case sizes such as C3225, C4532 and C5750 types are more likely to be affected by heat stress from the substrate. Please inquire separate specification for the large case sizes when mounted on the substrate.

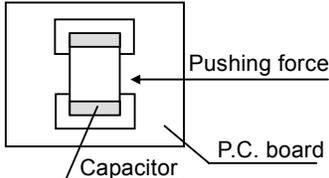
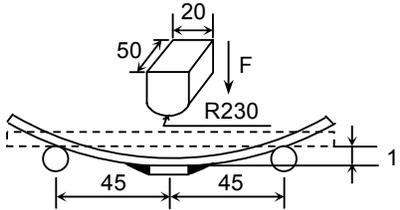
7. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the local Industrial Waste Laws.

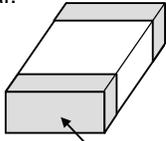
8. PERFORMANCE

No.	Item	Performance	Test or inspection method																	
1	External Appearance	No defects which may affect performance.	Inspect with magnifying glass (3×).																	
2	Insulation Resistance	10,000MΩ or 500MΩ·μF min. whichever smaller.	Apply rated voltage for 60s. As for the rated voltage 630V DC, apply 500V DC.																	
3	Voltage Proof	Withstand test voltage without insulation breakdown or other damage.	<table border="1"> <thead> <tr> <th>Class</th> <th>Rated voltage</th> <th>Apply voltage</th> </tr> </thead> <tbody> <tr> <td rowspan="2">Class 1</td> <td>100V</td> <td>3 × rated voltage</td> </tr> <tr> <td>Over 100V</td> <td>1.5 × rated voltage</td> </tr> <tr> <td rowspan="2">Class 2</td> <td>100V</td> <td>2.5 × rated voltage</td> </tr> <tr> <td>Over 100V</td> <td>1.5 × rated voltage</td> </tr> </tbody> </table> <p>Above DC voltage shall be applied for 1 to 5s. Charge / discharge current shall not exceed 50mA.</p>	Class	Rated voltage	Apply voltage	Class 1	100V	3 × rated voltage	Over 100V	1.5 × rated voltage	Class 2	100V	2.5 × rated voltage	Over 100V	1.5 × rated voltage				
Class	Rated voltage	Apply voltage																		
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	Over 100V	1.5 × rated voltage																		
Class 2	100V	2.5 × rated voltage																		
	Over 100V	1.5 × rated voltage																		
4	Capacitance	Within the specified capacitance.	<table border="1"> <thead> <tr> <th>Class</th> <th>Rated Capacitance</th> <th>Measuring frequency</th> <th>Measuring voltage</th> </tr> </thead> <tbody> <tr> <td rowspan="2">Class 1</td> <td>1000pF and under</td> <td>1MHz±10%</td> <td rowspan="2">0.5-5Vrms.</td> </tr> <tr> <td>Over 1000pF</td> <td>1kHz±10%</td> </tr> <tr> <td rowspan="2">Class 2</td> <td>10uF and under</td> <td>1kHz±10%</td> <td>1.0±0.2Vrms.</td> </tr> <tr> <td>Over 10uF</td> <td>120Hz±20%</td> <td>0.5±0.2Vrms.</td> </tr> </tbody> </table>	Class	Rated Capacitance	Measuring frequency	Measuring voltage	Class 1	1000pF and under	1MHz±10%	0.5-5Vrms.	Over 1000pF	1kHz±10%	Class 2	10uF and under	1kHz±10%	1.0±0.2Vrms.	Over 10uF	120Hz±20%	0.5±0.2Vrms.
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	Over 10uF	120Hz±20%	0.5±0.2Vrms.																	
5	Q (Class 1)	1,000 min.	See No.4 in this table for measuring condition.																	
6	Dissipation Factor (Class 2)	<table border="1"> <thead> <tr> <th>T.C.</th> <th>D.F.</th> </tr> </thead> <tbody> <tr> <td>X7R</td> <td>0.03 max.</td> </tr> <tr> <td>X7R</td> <td>0.05 max.</td> </tr> <tr> <td>X7T</td> <td>0.025 max.</td> </tr> </tbody> </table>	T.C.	D.F.	X7R	0.03 max.	X7R	0.05 max.	X7T	0.025 max.	See No.4 in this table for measuring condition.									
T.C.	D.F.																			
X7R	0.03 max.																			
X7R	0.05 max.																			
X7T	0.025 max.																			

(8. Performance, continued)

No.	Item	Performance	Test or inspection method										
7	Temperature Characteristics of Capacitance (Class 1)	<table border="1" data-bbox="574 226 920 380"> <tr> <td data-bbox="574 226 654 306">T.C.</td> <td data-bbox="654 226 920 306">Temperature Coefficient (ppm/°C)</td> </tr> <tr> <td data-bbox="574 306 654 380">C0G</td> <td data-bbox="654 306 920 380">0 ± 30</td> </tr> </table> <p data-bbox="574 422 920 453">Capacitance drift within ± 0.2%</p>	T.C.	Temperature Coefficient (ppm/°C)	C0G	0 ± 30	<p data-bbox="963 201 1419 302">Temperature coefficient shall be calculated based on values at 25°C and 85°C temperature.</p> <p data-bbox="963 348 1427 415">Measuring temperature below 20°C shall be -10°C and -25°C.</p>						
T.C.	Temperature Coefficient (ppm/°C)												
C0G	0 ± 30												
8	Temperature Characteristics of Capacitance (Class 2)	<p data-bbox="607 501 889 533">Capacitance Change (%)</p> <p data-bbox="647 562 862 594">No voltage applied</p> <p data-bbox="670 646 829 678">X7R : ±15%</p> <p data-bbox="670 682 829 714">X7S : ±22%</p> <p data-bbox="670 718 902 749">X7T : +22%, -33%</p>	<p data-bbox="963 491 1411 632">Capacitance shall be measured by the steps shown in the following table after thermal equilibrium is obtained for each step.</p> <p data-bbox="963 640 1382 672">ΔC be calculated ref. STEP3 reading</p> <table border="1" data-bbox="995 674 1403 978"> <thead> <tr> <th data-bbox="995 674 1075 737">Step</th> <th data-bbox="1075 674 1403 737">Temperature(°C)</th> </tr> </thead> <tbody> <tr> <td data-bbox="995 737 1075 800">1</td> <td data-bbox="1075 737 1403 800">Reference temp. ± 2</td> </tr> <tr> <td data-bbox="995 800 1075 863">2</td> <td data-bbox="1075 800 1403 863">Min. operating temp. ± 2</td> </tr> <tr> <td data-bbox="995 863 1075 926">3</td> <td data-bbox="1075 863 1403 926">Reference temp. ± 2</td> </tr> <tr> <td data-bbox="995 926 1075 978">4</td> <td data-bbox="1075 926 1403 978">Max. operating temp. ± 2</td> </tr> </tbody> </table>	Step	Temperature(°C)	1	Reference temp. ± 2	2	Min. operating temp. ± 2	3	Reference temp. ± 2	4	Max. operating temp. ± 2
Step	Temperature(°C)												
1	Reference temp. ± 2												
2	Min. operating temp. ± 2												
3	Reference temp. ± 2												
4	Max. operating temp. ± 2												
9	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.	<p data-bbox="963 989 1414 1199">Reflow solder the capacitors on P.C. board (shown in Appendix 1a or Appendix 1b) and apply a pushing force of 2N (C1005) or 5N (C1608, C2012, C3216, C3225, C4532, C5750) with 10±1s.</p> 										
10	Bending	No mechanical damage.	<p data-bbox="963 1394 1373 1495">Reflow solder the capacitors on P.C. board (shown in Appendix 2a or Appendix 2b) and bend 1mm.</p>  <p data-bbox="1308 1730 1432 1757">(Unit: mm)</p>										

(8. Performance, continued)

No.	Item	Performance	Test or inspection method											
11	Solderability	<p>New solder to cover over 75% of termination. 25% may have pin holes or rough spots but not concentrated in one spot. Ceramic surface of A sections shall not be exposed due to melting or shifting of termination material.</p>  <p style="text-align: center;">A section</p>	<p>Completely soak both terminations in solder at 235±5°C for 2±0.5s.</p> <p>Solder : H63A (JIS Z 3282)</p> <p>Flux : Isopropyl alcohol (JIS K 8839) Rosin(JIS K 5902) 25% solid solution.</p>											
12	Resistance to solder heat	External appearance	No cracks are allowed and terminations shall be covered at least 60% with new solder.											
		Capacitance	<table border="1"> <thead> <tr> <th colspan="2">Characteristics</th> <th>Change from the value before test</th> </tr> </thead> <tbody> <tr> <td>Class1</td> <td>C0G</td> <td>± 2.5%</td> </tr> <tr> <td rowspan="3">Class2</td> <td>X7R</td> <td rowspan="3">± 7.5 %</td> </tr> <tr> <td>X7S</td> </tr> <tr> <td>X7T</td> </tr> </tbody> </table>	Characteristics		Change from the value before test	Class1	C0G	± 2.5%	Class2	X7R	± 7.5 %	X7S	X7T
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			Class1	C0G	± 2.5%									
		Class2	X7R	± 7.5 %										
			X7S											
X7T														
Q (Class 1)	1,000 min.													
D.F. (Class 2)	Meet the initial spec.													
Insulation Resistance	Meet the initial spec.													
Voltage proof	No insulation breakdown or other damage.													
			<p>Completely soak both terminations in solder at 260±5°C for 5±1s.</p> <p>Preheating condition Temp. : 150±10°C Time : 1 to 2min.</p> <p>Flux : Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution.</p> <p>Solder : H63A (JIS Z 3282)</p> <p>Leave the capacitor in ambient conditions for 6 to 24h (Class 1) or 24±2h (Class 2) before measurement.</p>											

(Performance, continued)

No.	Item		Performance	Test or inspection method															
13	Vibration	External appearance	No mechanical damage.	<p>Reflow solder the capacitor on a P.C. board (shown in Appendix 1a or Appendix 1b) before testing.</p> <p>Vibrate the capacitor with amplitude of 1.5mm P-P changing the frequencies from 10Hz to 55Hz and back to 10Hz in about 1min.</p> <p>Repeat this for 2h each in 3 perpendicular directions.</p>															
		Capacitance	Characteristics		Change from the value before test														
			Class 1		C0G	± 2.5 %													
			Class 2		X7R	± 7.5 %													
		X7S X7T																	
Q (Class 1)	1,000 min.																		
D.F. (Class 2)	Meet the initial spec.																		
14	Temperature cycle	External appearance	No mechanical damage.	<p>Reflow solder the capacitors on a P.C. board (shown in Appendix 1a or Appendix 1b) before testing.</p> <p>Expose the capacitor in the condition step1 through step 4, and repeat 5 times consecutively.</p> <p>Leave the capacitor in ambient conditions for 6 to 24h (Class 1) or 24±2h (Class 2) before measurement.</p> <table border="1"> <thead> <tr> <th>Step</th> <th>Temperature(°C)</th> <th>Time (min.)</th> </tr> </thead> <tbody> <tr> <td>1</td> <td>Min. operating temp. ±3</td> <td>30 ± 3</td> </tr> <tr> <td>2</td> <td>Reference Temp.</td> <td>2 - 5</td> </tr> <tr> <td>3</td> <td>Max. operating temp. ± 2</td> <td>30 ± 2</td> </tr> <tr> <td>4</td> <td>Reference Temp.</td> <td>2 - 5</td> </tr> </tbody> </table>	Step	Temperature(°C)	Time (min.)	1	Min. operating temp. ±3	30 ± 3	2	Reference Temp.	2 - 5	3	Max. operating temp. ± 2	30 ± 2	4	Reference Temp.	2 - 5
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		2	Reference Temp.		2 - 5														
		3	Max. operating temp. ± 2		30 ± 2														
		4	Reference Temp.		2 - 5														
		Capacitance	Characteristics		Change from the value before test														
Class 1	C0G		± 2.5 %																
Class 2	X7R		± 7.5 %																
	X7S X7T																		
Q (Class 1)	1,000 min.																		
D.F. (Class 2)	Meet the initial spec.																		
Insulation Resistance	Meet the initial spec.																		
Voltage proof	No insulation breakdown or other damage.																		

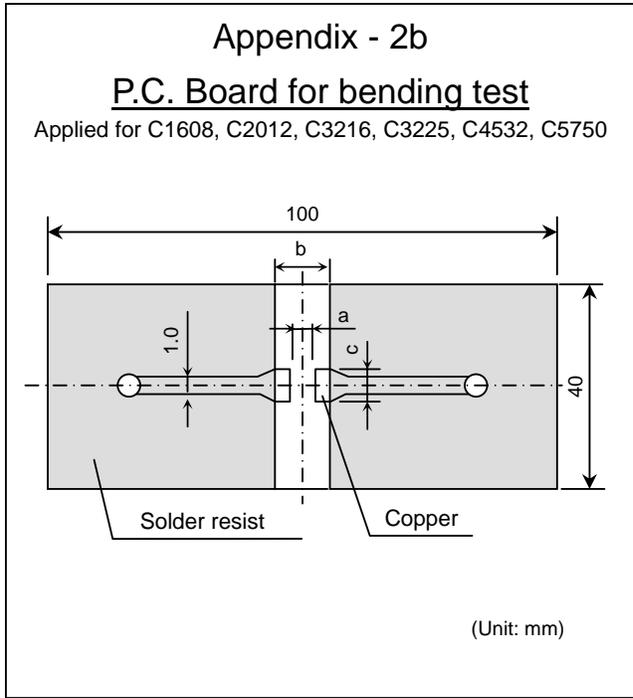
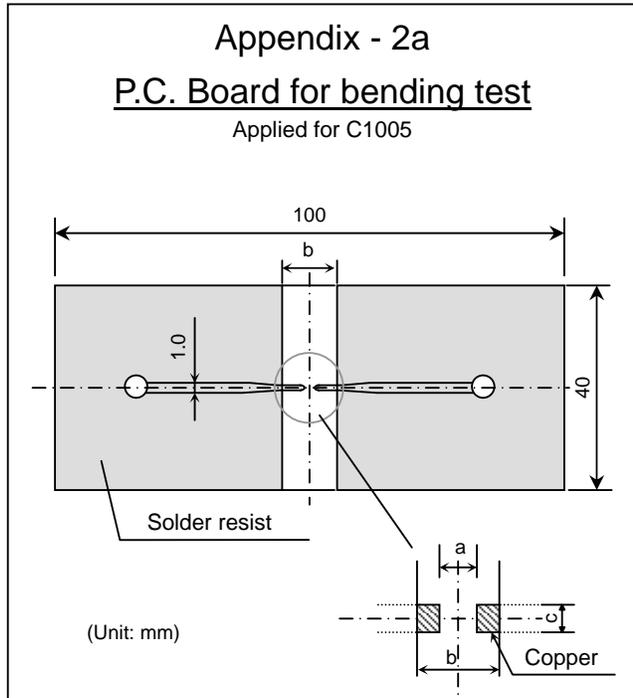
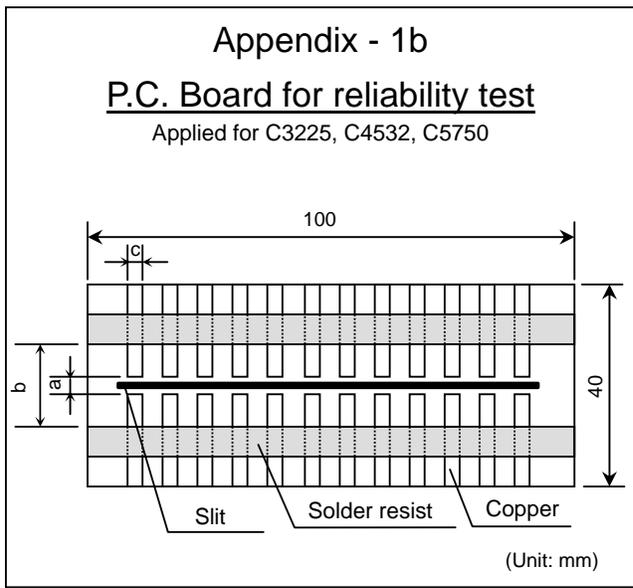
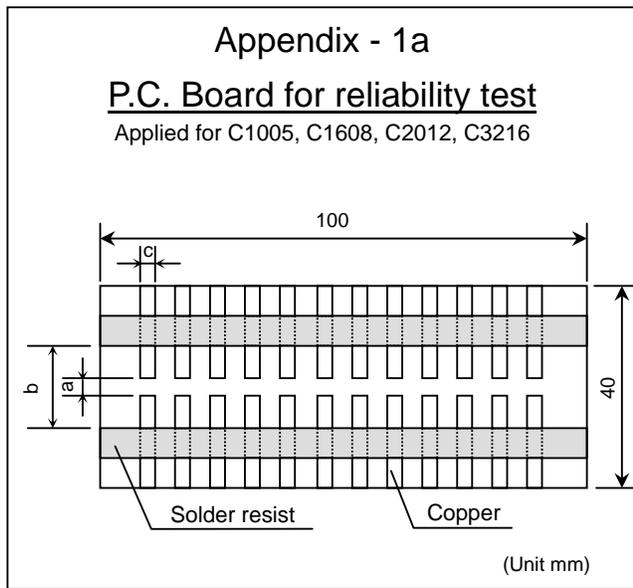
(8. Performance, continued)

No.	Item	Performance	Test or inspection method											
15	Moisture Resistance (Steady State)	External appearance	<p>Reflow solder the capacitor on P.C. board (shown in Appendix 1a or Appendix 1b) before testing.</p> <p>Leave at temperature 40±2°C, 90 to 95%RH for 500 +24,0h.</p> <p>Leave the capacitor in ambient condition for 6 to 24h (Class1) or 24±2h (Class 2) before measurement.</p>											
		Capacitance		<table border="1"> <tr> <td colspan="2">Characteristics</td> <td>Change from the value before test</td> </tr> <tr> <td>Class 1</td> <td>C0G</td> <td>± 5 %</td> </tr> <tr> <td rowspan="2">Class 2</td> <td>X7R</td> <td rowspan="2">± 12.5 %</td> </tr> <tr> <td>X7S X7T</td> </tr> </table>	Characteristics		Change from the value before test	Class 1	C0G	± 5 %	Class 2	X7R	± 12.5 %	X7S X7T
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				Class 1	C0G	± 5 %								
		Class 2		X7R	± 12.5 %									
X7S X7T														
Q (Class 1)	350 min.													
D.F. (Class 2)	Characteristics X7R/X7S/X7T : 200% of initial spec. max.													
Insulation Resistance	1,000MΩ or 50MΩ·μF min. whichever smaller.													
16	Moisture Resistance	External appearance	<p>Reflow solder the capacitors on P.C. board (shown in Appendix 1a or Appendix 1b) before testing.</p> <p>Apply the rated voltage at temperature 40±2°C and 90 to 95%RH for 500 +24,0h.</p> <p>Charge/discharge current shall not exceed 50mA.</p> <p>Leave the capacitor in ambient conditions for 6 to 24h (Class 1) or 24±2h (Class 2) before measurement.</p> <p>Voltage conditioning (only for class 2)Voltage treat the capacitors under testing temperature and voltage for 1 hour.</p> <p>Leave the capacitors in ambient condition for 24±2h before measurement.</p> <p>Use this measurement for initial value.</p>											
		Capacitance		<table border="1"> <tr> <td colspan="2">Characteristics</td> <td>Change from the value before test</td> </tr> <tr> <td>Class 1</td> <td>C0G</td> <td>± 7.5 %</td> </tr> <tr> <td rowspan="2">Class 2</td> <td>X7R</td> <td rowspan="2">± 12.5 %</td> </tr> <tr> <td>X7S X7T</td> </tr> </table>	Characteristics		Change from the value before test	Class 1	C0G	± 7.5 %	Class 2	X7R	± 12.5 %	X7S X7T
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Q (Class 1)	200 min.													
D.F. (Class 2)	Characteristics X7R/X7S/X7T : 200% of initial spec. max.													
Insulation Resistance	500MΩ or 25MΩ·μF min. whichever smaller.													

(8. Performance, continued)

No.	Item	Performance	Test or inspection method												
17	Life	External appearance	No mechanical damage.												
		Capacitance	<table border="1"> <thead> <tr> <th colspan="2">Characteristics</th> <th>Change from the value before test</th> </tr> </thead> <tbody> <tr> <td>Class 1</td> <td>C0G</td> <td>$\pm 3\%$</td> </tr> <tr> <td rowspan="3">Class 2</td> <td>X7R</td> <td rowspan="3">$\pm 15\%$</td> </tr> <tr> <td>X7S</td> </tr> <tr> <td>X7T</td> </tr> </tbody> </table>	Characteristics		Change from the value before test	Class 1	C0G	$\pm 3\%$	Class 2	X7R	$\pm 15\%$	X7S	X7T	<p>Reflow solder the capacitor on P.C. board (shown in Appendix 1a or Appendix 1b) before testing.</p> <p>Below the voltage shall be applied at $125\pm 2^{\circ}\text{C}$ for 1,000 +48, 0h.</p> <p>Applied voltage is 1xRV. Some items may be tested at higher voltage (1.2x, 1.5x or 2xRV).</p>
			Characteristics		Change from the value before test										
			Class 1	C0G	$\pm 3\%$										
		Class 2	X7R	$\pm 15\%$											
X7S															
X7T															
Q (Class 1)	350 min.														
D.F. (Class 2)	Characteristics X7R/X7S/X7T : 200% of initial spec. max.	Charge/discharge current shall not exceed 50mA.													
Insulation Resistance	1,000M Ω or 50M Ω · μF min. whichever smaller.	<p>Leave the capacitors in ambient condition for 6 to 24h (Class 1) or 24\pm2h (Class 2) before measurement.</p> <p>Voltage conditioning (only for class 2) Voltage treat the capacitor under testing temperature and voltage for 1 hour. Leave the capacitor in ambient conditions for 24\pm2h before measurement.</p> <p>Use this measurement for initial value.</p>													

*As for the initial measurement of capacitors (Class 2) on number 8, 12, 13, 14 and 15, leave capacitor at $150 - 10, 0^{\circ}\text{C}$ for 1 hour and measure the value after leaving capacitor for 24 \pm 2h in ambient condition.



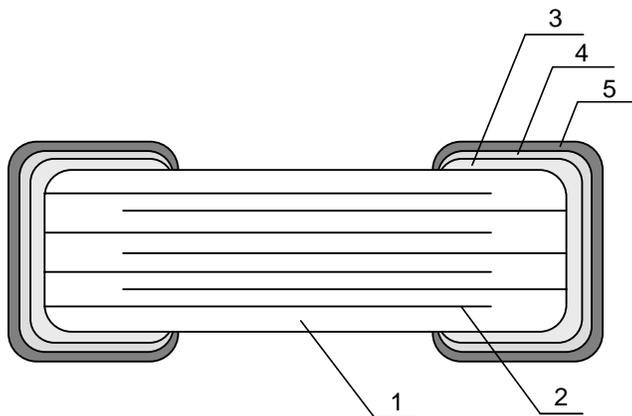
Material : Glass Epoxy (As per JIS C6484 GE4)

P.C. Board thickness : Appendix-2a 0.8mm
 Appendix-1a, 1b, 2b 1.6mm

- Copper (thickness 0.035mm)
- Solder resist

TDK (EIA style)	Dimensions (mm)		
	a	b	c
C1005 (CC0402)	0.4	1.5	0.5
C1608 (CC0603)	1.0	3.0	1.2
C2012 (CC0805)	1.2	4.0	1.65
C3216 (CC1206)	2.2	5.0	2.0
C3225 (CC1210)	2.2	5.0	2.9
C4532 (CC1812)	3.5	7.0	3.7
C5750 (CC2220)	4.5	8.0	5.6

9. INSIDE STRUCTURE AND MATERIAL



No.	NAME	MATERIAL	
		Class 1	Class 2
1	Dielectric	CaZrO ₃	BaTiO ₃
2	Electrode	Nickel (Ni)	
3	Termination	Copper (Cu)	
4		Nickel (Ni)	
5		Tin (Sn)	

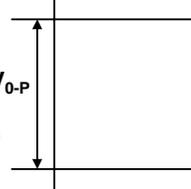
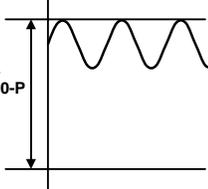
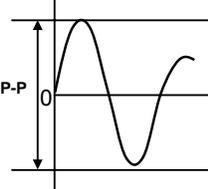
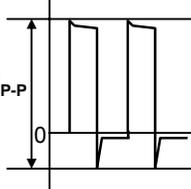
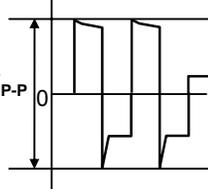
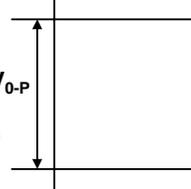
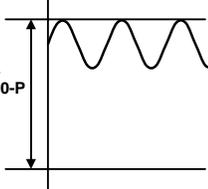
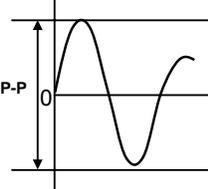
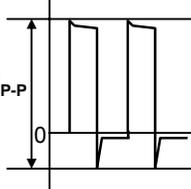
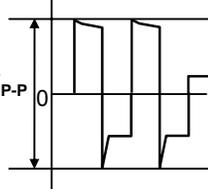
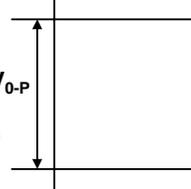
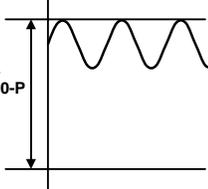
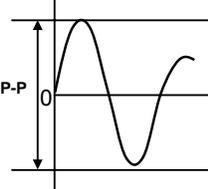
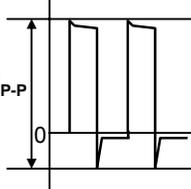
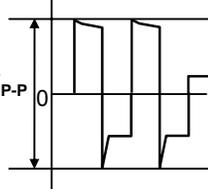
10. RECOMMENDATION

As for C3225, C4532 and C5750 types, it is recommended to provide a slit (about 1mm wide) in the board under the components to improve washing flux. Please make sure to completely remove all cleaning solvents.

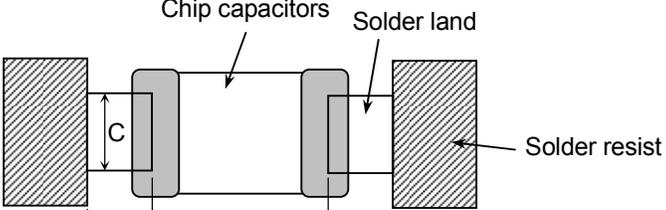
11. SOLDERING CONDITION

For C1608 (CC0603) ~ C3216 (CC1206) case size, TDK recommends reflow or wave soldering. Smaller case sizes, C0603 (CC0201) ~ C1005 (CC0402), and larger case sizes, C3225 (CC1210) ~ C5750 (CC2220), should use reflow solder only. See "Caution" Section No.5 for details.

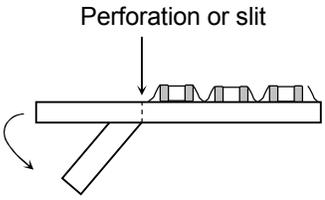
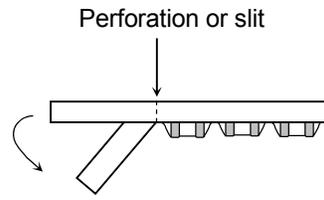
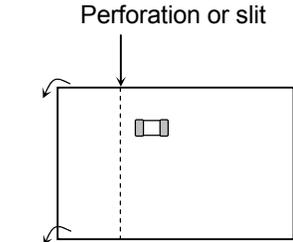
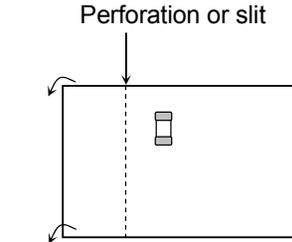
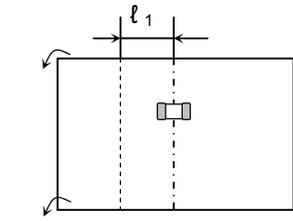
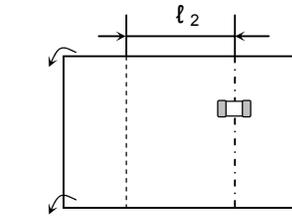
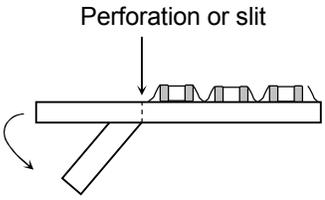
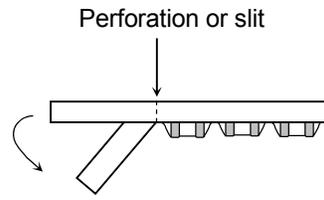
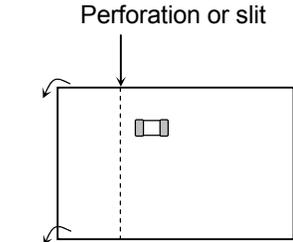
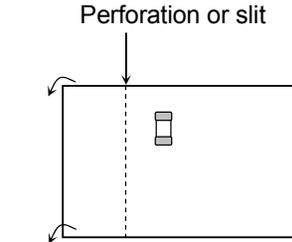
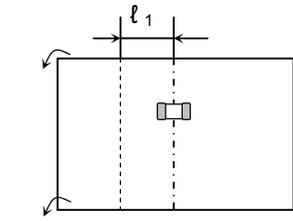
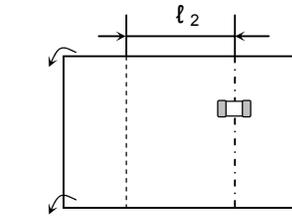
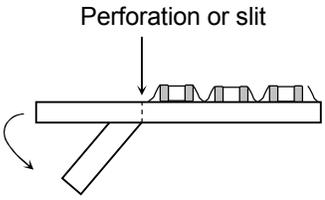
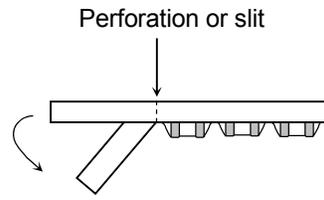
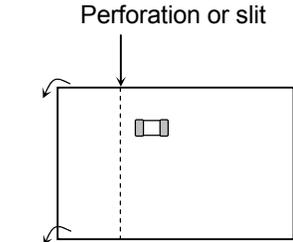
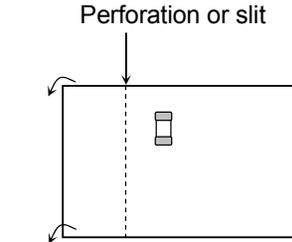
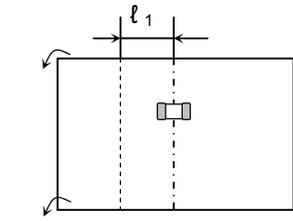
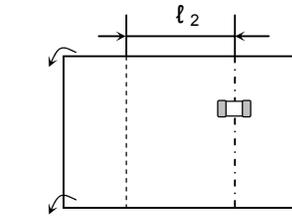
12. Caution

No.	Process	Condition														
1	Operating Condition (Storage, Transportation)	<p>1.1 Storage</p> <ol style="list-style-type: none"> The capacitor must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt. The capacitor must be operated and stored in an environment free of condensation and corrosive gases such as hydrogen sulphide, hydrogen sulphate, chlorine, ammonia and sulfur. Avoid storing in sun light and falling of dew. Do not use capacitors under high humidity and high and low atmospheric pressure which may affect capacitors reliability. Capacitors should be tested for the solderability when they are stored for long time. <p>1.2 Handling in transportation In case of the transportation, the performance of the capacitor may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335B 9.2 "Handling in Transportation")</p>														
2	Circuit design	<p>2.1 Operating temperature Operating temperature should be followed strictly within this specification.</p> <ol style="list-style-type: none"> Do not use capacitors above the maximum allowable operating temperature. Surface temperature including self heating should be below maximum operating temperature. (Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product its mounted on. Please design the circuit so that the maximum temperature of the capacitors (including the self heating) will be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be below 20°C) The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration. <p>2.2 Operating voltage</p> <ol style="list-style-type: none"> Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V_{0-P} must be below the rated voltage. Reference figures 1 and 2 below. AC or pulse with overshooting, V_{P-P} must be below the rated voltage. Reference: figures 3, 4, and 5 below. When the voltage is started/stopped to the circuit An irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitor within rated voltage containing these Irregular voltage periods. <table border="1" data-bbox="506 1318 1416 1575"> <thead> <tr> <th data-bbox="506 1318 685 1360">Voltage</th> <th data-bbox="685 1318 928 1360">(1) DC voltage</th> <th data-bbox="928 1318 1172 1360">(2) DC+AC voltage</th> <th data-bbox="1172 1318 1416 1360">(3) AC voltage</th> </tr> </thead> <tbody> <tr> <td data-bbox="506 1360 685 1575">Positional Measurement (Rated voltage)</td> <td data-bbox="685 1360 928 1575">  </td> <td data-bbox="928 1360 1172 1575">  </td> <td data-bbox="1172 1360 1416 1575">  </td> </tr> </tbody> </table> <table border="1" data-bbox="506 1600 1172 1852"> <thead> <tr> <th data-bbox="506 1600 685 1642">Voltage</th> <th data-bbox="685 1600 928 1642">(4) Pulse voltage (A)</th> <th data-bbox="928 1600 1172 1642">(5) Pulse voltage (B)</th> </tr> </thead> <tbody> <tr> <td data-bbox="506 1642 685 1852">Positional Measurement (Rated voltage)</td> <td data-bbox="685 1642 928 1852">  </td> <td data-bbox="928 1642 1172 1852">  </td> </tr> </tbody> </table>	Voltage	(1) DC voltage	(2) DC+AC voltage	(3) AC voltage	Positional Measurement (Rated voltage)				Voltage	(4) Pulse voltage (A)	(5) Pulse voltage (B)	Positional Measurement (Rated voltage)		
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(12. Caution, continued)

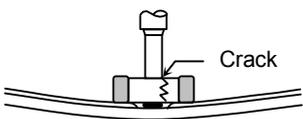
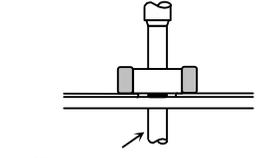
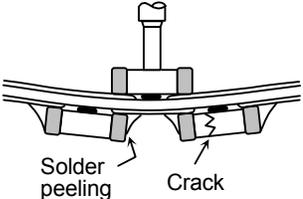
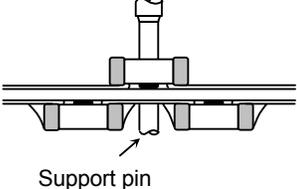
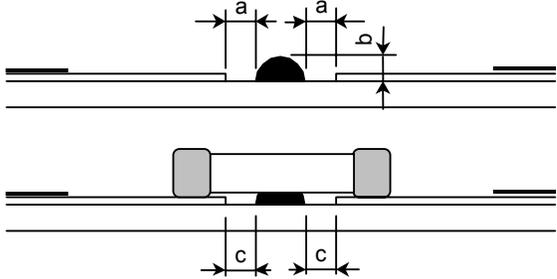
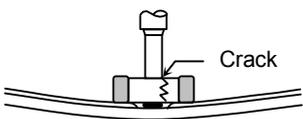
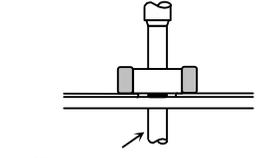
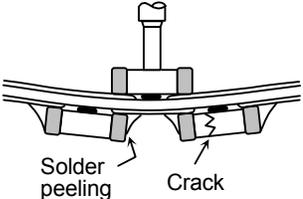
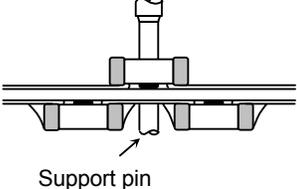
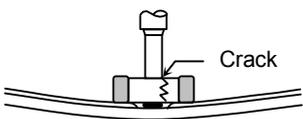
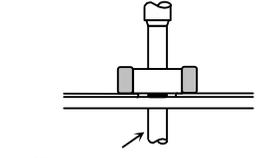
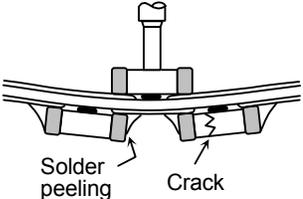
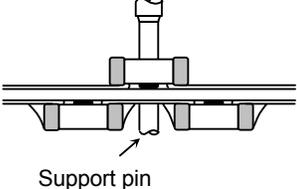
No.	Process	Condition																																																				
2	Circuit design	<p>2.2 Operating Voltage (continued)</p> <p>2. Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced.</p> <p>3. The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration.</p> <p>2.3 Frequency</p> <p>When Class 2 capacitors are used in AC and/or pulsed voltages, the capacitors may self vibrate and generate audible sound (piezoelectric affect)</p>																																																				
3	Designing P.C. Board	<p>The amount of solder at the terminations has a direct effect on the reliability of the capacitors.</p> <p>1. The greater the amount of solder, the higher the stress on the chip capacitor, and the more likely that it will break. When designing a P.C.board, determine the shape and size of the solder lands to have proper amount of solder on the terminations.</p> <p>2. Avoid using common solder land for multiple terminations and provide individual solder land for each terminations instead.</p> <p>3. Size and recommended land dimensions provided below:</p> <div style="text-align: center;">  </div> <table border="1" data-bbox="532 1081 1279 1318"> <caption>Flow soldering (mm)</caption> <thead> <tr> <th>Type</th> <th>C1608 [CC0603]</th> <th>C2012 [CC0805]</th> <th>C3216 [CC1206]</th> </tr> </thead> <tbody> <tr> <td>A</td> <td>0.7 - 1.0</td> <td>1.0 - 1.3</td> <td>2.1 - 2.5</td> </tr> <tr> <td>B</td> <td>0.8 - 1.0</td> <td>1.0 - 1.2</td> <td>1.1 - 1.3</td> </tr> <tr> <td>C</td> <td>0.6 - 0.8</td> <td>0.8 - 1.1</td> <td>1.0 - 1.3</td> </tr> </tbody> </table> <table border="1" data-bbox="516 1360 1383 1591"> <caption>Reflow soldering (mm)</caption> <thead> <tr> <th>Type</th> <th>C1005 [CC0402]</th> <th>C1608 [C0603]</th> <th>C2012 [CC0805]</th> <th>C3216 [CC1206]</th> </tr> </thead> <tbody> <tr> <td>A</td> <td>0.3 - 0.5</td> <td>0.6 - 0.8</td> <td>0.9 - 1.2</td> <td>2.0 - 2.4</td> </tr> <tr> <td>B</td> <td>0.35 - 0.45</td> <td>0.6 - 0.8</td> <td>0.7 - 0.9</td> <td>1.0 - 1.2</td> </tr> <tr> <td>C</td> <td>0.4 - 0.6</td> <td>0.6 - 0.8</td> <td>0.9 - 1.2</td> <td>1.1 - 1.6</td> </tr> </tbody> </table> <table border="1" data-bbox="516 1627 1209 1831"> <thead> <tr> <th>Type</th> <th>C3225 [CC1210]</th> <th>C4532 [CC1812]</th> <th>C5750 [CC2220]</th> </tr> </thead> <tbody> <tr> <td>A</td> <td>2.0 - 2.4</td> <td>3.1 - 3.7</td> <td>4.1 - 4.8</td> </tr> <tr> <td>B</td> <td>1.0 - 1.2</td> <td>1.2 - 1.4</td> <td>1.2 - 1.4</td> </tr> <tr> <td>C</td> <td>1.9 - 2.5</td> <td>2.4 - 3.2</td> <td>4.0 - 5.0</td> </tr> </tbody> </table>	Type	C1608 [CC0603]	C2012 [CC0805]	C3216 [CC1206]	A	0.7 - 1.0	1.0 - 1.3	2.1 - 2.5	B	0.8 - 1.0	1.0 - 1.2	1.1 - 1.3	C	0.6 - 0.8	0.8 - 1.1	1.0 - 1.3	Type	C1005 [CC0402]	C1608 [C0603]	C2012 [CC0805]	C3216 [CC1206]	A	0.3 - 0.5	0.6 - 0.8	0.9 - 1.2	2.0 - 2.4	B	0.35 - 0.45	0.6 - 0.8	0.7 - 0.9	1.0 - 1.2	C	0.4 - 0.6	0.6 - 0.8	0.9 - 1.2	1.1 - 1.6	Type	C3225 [CC1210]	C4532 [CC1812]	C5750 [CC2220]	A	2.0 - 2.4	3.1 - 3.7	4.1 - 4.8	B	1.0 - 1.2	1.2 - 1.4	1.2 - 1.4	C	1.9 - 2.5	2.4 - 3.2	4.0 - 5.0
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(12. Caution, continued)

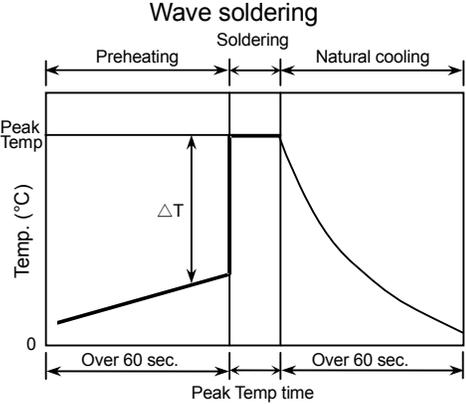
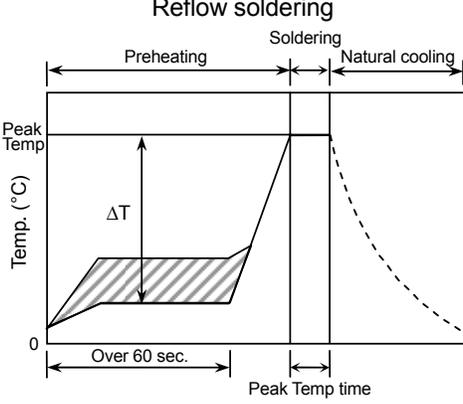
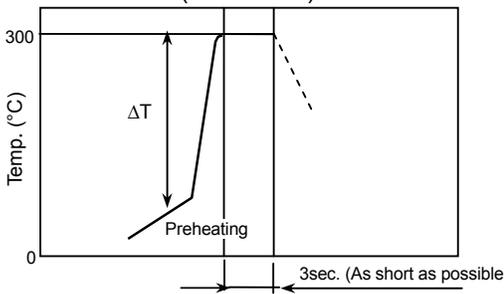
No.	Process	Condition												
3	Designing P.C. Board	<p>4. Recommended chip capacitor layout is provided below:</p> <table border="1"> <thead> <tr> <th data-bbox="509 233 683 306"></th> <th data-bbox="683 233 1040 306">Disadvantage against bending stress</th> <th data-bbox="1040 233 1398 306">Advantage against bending stress</th> </tr> </thead> <tbody> <tr> <td data-bbox="509 306 683 695">Mounting face</td> <td data-bbox="683 306 1040 695"> <p>Perforation or slit</p>  <p>Break P.C. board with mounted side up.</p> </td> <td data-bbox="1040 306 1398 695"> <p>Perforation or slit</p>  <p>Break P.C. board with mounted side down.</p> </td> </tr> <tr> <td data-bbox="509 695 683 1115">Chip arrangement (Direction)</td> <td data-bbox="683 695 1040 1115"> <p>Mount perpendicularly to perforation or slit</p> <p>Perforation or slit</p>  </td> <td data-bbox="1040 695 1398 1115"> <p>Mount in parallel with perforation or slit</p> <p>Perforation or slit</p>  </td> </tr> <tr> <td data-bbox="509 1115 683 1566">Distance from slit</td> <td data-bbox="683 1115 1040 1566"> <p>Closer to slit is higher stress</p>  <p>$(l_1 < l_2)$</p> </td> <td data-bbox="1040 1115 1398 1566"> <p>Away from slit is less stress</p>  <p>$(l_1 < l_2)$</p> </td> </tr> </tbody> </table>		Disadvantage against bending stress	Advantage against bending stress	Mounting face	<p>Perforation or slit</p>  <p>Break P.C. board with mounted side up.</p>	<p>Perforation or slit</p>  <p>Break P.C. board with mounted side down.</p>	Chip arrangement (Direction)	<p>Mount perpendicularly to perforation or slit</p> <p>Perforation or slit</p> 	<p>Mount in parallel with perforation or slit</p> <p>Perforation or slit</p> 	Distance from slit	<p>Closer to slit is higher stress</p>  <p>$(l_1 < l_2)$</p>	<p>Away from slit is less stress</p>  <p>$(l_1 < l_2)$</p>
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Distance from slit	<p>Closer to slit is higher stress</p>  <p>$(l_1 < l_2)$</p>	<p>Away from slit is less stress</p>  <p>$(l_1 < l_2)$</p>												

No.	Process	Condition												
3	Designing P.C. Board	<p data-bbox="423 170 1365 199">5. Mechanical stress varies according to location of chip capacitors on the P.C.board.</p> <div data-bbox="527 254 1279 779" style="text-align: center;"> </div> <p data-bbox="472 829 1370 884">The relative stress applied to these capacitors during depaneling is in the following order:</p> <p data-bbox="854 888 1052 913" style="text-align: center;">$A > B = C > D > E$</p> <p data-bbox="423 930 732 959">6. Layout recommendation</p> <table border="1" data-bbox="418 972 1448 1829"> <thead> <tr> <th data-bbox="418 972 570 1079">Example</th> <th data-bbox="574 972 854 1079">Use of common solder land</th> <th data-bbox="859 972 1138 1079">Soldering with chassis</th> <th data-bbox="1143 972 1448 1079">Use of common solder land with other SMD</th> </tr> </thead> <tbody> <tr> <td data-bbox="418 1085 570 1440">Need to avoid</td> <td data-bbox="574 1085 854 1440"> </td> <td data-bbox="859 1085 1138 1440"> </td> <td data-bbox="1143 1085 1448 1440"> </td> </tr> <tr> <td data-bbox="418 1446 570 1829">Recommendation</td> <td data-bbox="574 1446 854 1829"> </td> <td data-bbox="859 1446 1138 1829"> </td> <td data-bbox="1143 1446 1448 1829"> </td> </tr> </tbody> </table>	Example	Use of common solder land	Soldering with chassis	Use of common solder land with other SMD	Need to avoid				Recommendation			
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Need to avoid														
Recommendation														

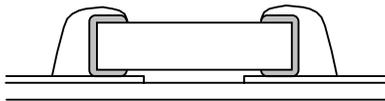
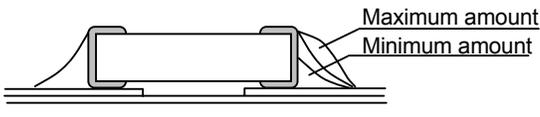
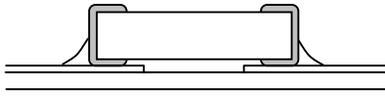
(12. Caution, continued)

No.	Process	Condition															
4	Mounting	<p>4.1 Stress from mounting head</p> <p>If the mounting head is adjusted too low, it may induce excessive stress on the chip capacitor and result in cracking. Please take following precautions.</p> <ol style="list-style-type: none"> 1. Adjust the bottom dead center of the mounting head to reach on the P.C. board surface but not contact it. 2. Adjust the mounting head pressure to be 1 to 3N of static weight. 3. To minimize the impact energy from mounting head, it is important to provide support from the bottom side of the P.C.board. <p>See following examples.</p> <table border="1" data-bbox="516 558 1403 1087"> <thead> <tr> <th></th> <th data-bbox="691 558 1057 611">Not recommended</th> <th data-bbox="1057 558 1403 611">Recommended</th> </tr> </thead> <tbody> <tr> <td data-bbox="516 611 691 842">Single sided mounting</td> <td data-bbox="691 611 1057 842">  </td> <td data-bbox="1057 611 1403 842">  </td> </tr> <tr> <td data-bbox="516 842 691 1087">Double-sided mounting</td> <td data-bbox="691 842 1057 1087">  </td> <td data-bbox="1057 842 1403 1087">  </td> </tr> </tbody> </table> <p>When the centering jaw is worn , it may give mechanical impact on the capacitor may occur and damage the product. Please control the closing dimension of the centering jaw and provide sufficient preventive maintenance and/or replacement if necessary.</p> <p>4.2 Amount of adhesive</p>  <p>Example : C2012 (CC0805), C3216 (CC1206)</p> <table border="1" data-bbox="683 1671 1200 1822"> <tbody> <tr> <td data-bbox="683 1671 821 1724">a</td> <td data-bbox="821 1671 1200 1724">0.2mm min.</td> </tr> <tr> <td data-bbox="683 1724 821 1776">b</td> <td data-bbox="821 1724 1200 1776">70 - 100μm</td> </tr> <tr> <td data-bbox="683 1776 821 1822">c</td> <td data-bbox="821 1776 1200 1822">Do not touch the solder land</td> </tr> </tbody> </table>		Not recommended	Recommended	Single sided mounting			Double-sided mounting			a	0.2mm min.	b	70 - 100μm	c	Do not touch the solder land
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c	Do not touch the solder land																

(12. Caution, continued)

No.	Process	Condition																			
5	Soldering	<p>5.1 Flux selection</p> <p>Although highly-activated flux gives better solderability, substances which increase activity may also degrade the insulation of the chip capacitor. To avoid such degradation, the following is recommended.</p> <ol style="list-style-type: none"> 1. Use a mildly activated rosin flux (less than 0.1wt% chlorine). 2. Excessive flux must be avoided. Please provide proper amount of flux. 3. When water-soluble flux is used, sufficient washing is necessary. <p>5.2 Recommended soldering profile by various methods</p> <div style="display: flex; justify-content: space-around;"> <div style="text-align: center;"> <p>Wave soldering</p>  </div> <div style="text-align: center;"> <p>Reflow soldering</p>  </div> </div> <div style="text-align: center; margin-top: 20px;"> <p>Manual soldering (Solder iron)</p>  </div> <div style="margin-top: 20px;"> <p>APPLICATION</p> <p>As for C1608 (CC0603), C2012 (CC0805) and C3216 (CC1206), applied to wave soldering and reflow soldering.</p> <p>As for C1005 (CC0402), C3225 (CC1210), C4532 (CC1812), C5750 (CC2220), applied only to reflow soldering.</p> </div> <p>5.3. Recommended soldering peak temp and duration</p> <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th rowspan="2" style="text-align: center;">Temp./Duration</th> <th colspan="2" style="text-align: center;">Wave soldering</th> <th colspan="2" style="text-align: center;">Reflow soldering</th> </tr> <tr> <th style="text-align: center;">Peak temp(°C)</th> <th style="text-align: center;">Duration(sec.)</th> <th style="text-align: center;">Peak temp(°C)</th> <th style="text-align: center;">Duration(sec.)</th> </tr> </thead> <tbody> <tr> <td style="text-align: center;">Sn-Pb Solder</td> <td style="text-align: center;">250 max.</td> <td style="text-align: center;">3 max.</td> <td style="text-align: center;">230 max.</td> <td style="text-align: center;">20 max.</td> </tr> <tr> <td style="text-align: center;">Lead Free Solder</td> <td style="text-align: center;">260 max.</td> <td style="text-align: center;">5 max.</td> <td style="text-align: center;">260 max.</td> <td style="text-align: center;">10 max.</td> </tr> </tbody> </table> <p>Recommended solder compositions</p> <p>Sn-37Pb (Sn-Pb solder)</p> <p>Sn-3.0Ag-0.5Cu (Lead Free Solder)</p>	Temp./Duration	Wave soldering		Reflow soldering		Peak temp(°C)	Duration(sec.)	Peak temp(°C)	Duration(sec.)	Sn-Pb Solder	250 max.	3 max.	230 max.	20 max.	Lead Free Solder	260 max.	5 max.	260 max.	10 max.
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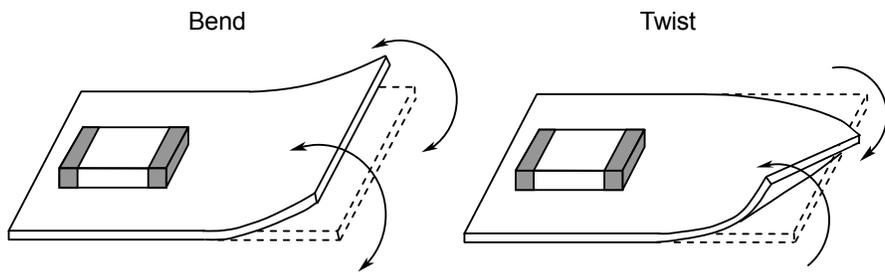
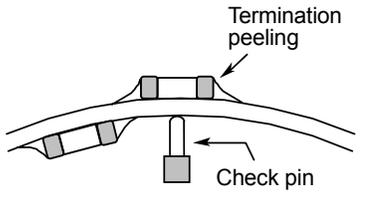
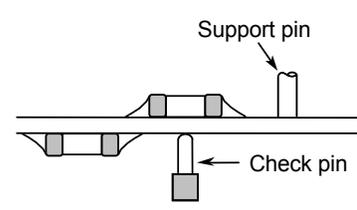
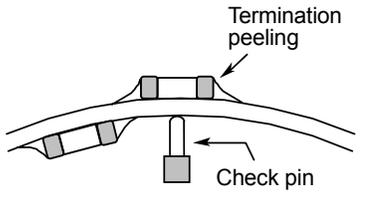
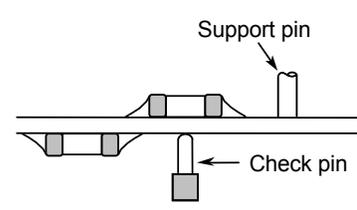
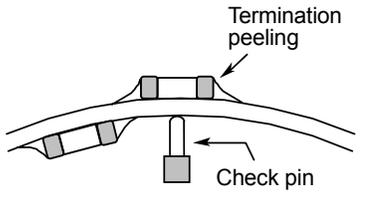
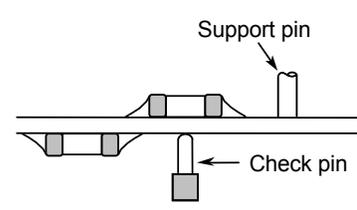
(12. Caution, continued)

No.	Process	Condition																				
5	Soldering (continued)	<p data-bbox="483 178 781 210">5.4 Avoiding thermal shock</p> <p data-bbox="483 216 756 247">1. Preheating condition</p> <table border="1" data-bbox="581 247 1398 594"> <thead> <tr> <th data-bbox="581 247 792 279">Soldering</th> <th data-bbox="792 247 1203 279">Type</th> <th data-bbox="1203 247 1398 279">Temp. (°C)</th> </tr> </thead> <tbody> <tr> <td data-bbox="581 279 792 348">Wave soldering</td> <td data-bbox="792 279 1203 348">C1608(CC0603), C2012(CC0805), C3216(CC1206)</td> <td data-bbox="1203 279 1398 348">$\Delta T \leq 150$</td> </tr> <tr> <td data-bbox="581 348 792 470">Reflow soldering</td> <td data-bbox="792 348 1203 470">C1005(CC0402), C1608(CC0603), C2012(CC0805), C3216(CC1206) C3225(CC1210), C4532(CC1812), C5750(CC2220)</td> <td data-bbox="1203 348 1398 470">$\Delta T \leq 150$ $\Delta T \leq 130$</td> </tr> <tr> <td data-bbox="581 470 792 594">Manual soldering</td> <td data-bbox="792 470 1203 594">C1005(CC0402), C1608(CC0603), C2012(CC0805), C3216(CC1206) C3225(CC1210), C4532(CC1812), C5750(CC2220)</td> <td data-bbox="1203 470 1398 594">$\Delta T \leq 150$ $\Delta T \leq 130$</td> </tr> </tbody> </table> <p data-bbox="483 636 732 667">2. Cooling condition</p> <p data-bbox="532 674 1430 743">Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (ΔT) must be less than 100°C.</p> <p data-bbox="483 785 711 816">5.5 Amount of solder</p> <p data-bbox="565 823 1442 930">Excessive solder will induce higher tensile force on the chip capacitor during temperature changes and may result in chip cracking. Insufficient solder may detach the capacitor from the P.C. board.</p> <div data-bbox="537 961 1414 1079"> <p data-bbox="537 974 656 1043">Excessive solder</p>  <p data-bbox="1122 961 1377 1058">Higher tensile force on the chip capacitor may cause cracking</p> </div> <div data-bbox="537 1094 1414 1211"> <p data-bbox="537 1136 651 1167">Adequate</p>  </div> <div data-bbox="537 1226 1414 1367"> <p data-bbox="537 1262 662 1331">Insufficient solder</p>  <p data-bbox="1122 1226 1382 1367">Small solder fillet may cause contact failure or not hold the chip capacitor to the P.C. board.</p> </div> <p data-bbox="483 1409 821 1440">5.6 Solder repair by solder iron</p> <p data-bbox="483 1446 886 1478">1. Selection of the soldering iron tip</p> <p data-bbox="537 1478 1403 1654">Tip temperature of solder iron varies by its type, P.C. board material and solder land size. Higher temperatures, may provide the quicker operation, however, heat shock may cause a crack in the chip capacitor. Please confirm the tip temperature, before soldering and keep the peak temperature and time in accordance with following recommended condition. (Please preheat the chip capacitors with the condition in 5.4 to avoid the thermal shock.)</p> <p data-bbox="553 1682 1365 1713">Recommended solder iron condition (Sn-Pb Solder and Lead Free Solder)</p> <table border="1" data-bbox="581 1713 1360 1818"> <thead> <tr> <th data-bbox="581 1713 776 1766">Temp. (°C)</th> <th data-bbox="776 1713 971 1766">Duration (sec.)</th> <th data-bbox="971 1713 1166 1766">Wattage (W)</th> <th data-bbox="1166 1713 1360 1766">Shape (mm)</th> </tr> </thead> <tbody> <tr> <td data-bbox="581 1766 776 1818">300 max.</td> <td data-bbox="776 1766 971 1818">3 max.</td> <td data-bbox="971 1766 1166 1818">20 max.</td> <td data-bbox="1166 1766 1360 1818">Ø 3.0 max.</td> </tr> </tbody> </table>	Soldering	Type	Temp. (°C)	Wave soldering	C1608(CC0603), C2012(CC0805), C3216(CC1206)	$\Delta T \leq 150$	Reflow soldering	C1005(CC0402), C1608(CC0603), C2012(CC0805), C3216(CC1206) C3225(CC1210), C4532(CC1812), C5750(CC2220)	$\Delta T \leq 150$ $\Delta T \leq 130$	Manual soldering	C1005(CC0402), C1608(CC0603), C2012(CC0805), C3216(CC1206) C3225(CC1210), C4532(CC1812), C5750(CC2220)	$\Delta T \leq 150$ $\Delta T \leq 130$	Temp. (°C)	Duration (sec.)	Wattage (W)	Shape (mm)	300 max.	3 max.	20 max.	Ø 3.0 max.
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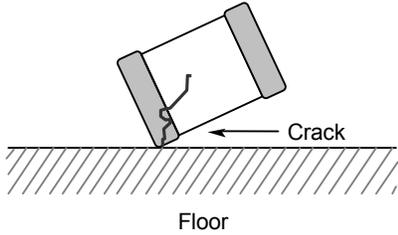
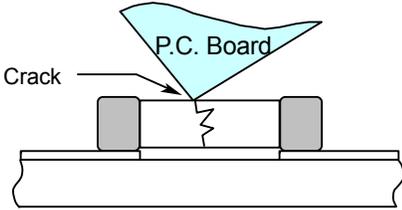
(12. Caution, continued)

No.	Process	Condition
5	Soldering (continued)	<p>2. Direct contact of the soldering iron with ceramic dielectric of the chip capacitor may causing crack. Do not touch the ceramic dielectric and the terminations by solder iron.</p> <p>5.7 Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder.</p> <p>5.8 Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335B Annex 1 "Recommendations to prevent the tombstone phenomenon".)</p>
6	Cleaning	<p>1. If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to this chip capacitor surface and deteriorate insulation resistance.</p> <p>2. If cleaning condition is not suitable, it determined the chip capacitor's insulation resistance.</p> <p>2.1. Insufficient washing</p> <ol style="list-style-type: none">1. Terminal electrodes may be corroded by Halogen in the flux.2. Halogen in the flux may adhere on the surface of capacitor, and lower the insulation resistance.3. Water soluble flux has higher tendency to have above mentioned problems (1) and (2). <p>2.2 Excessive washing</p> <p>When ultrasonic cleaning is used, excessively high energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, the following is recommended.</p> <p style="text-align: center;">Power: 20 W/ ℓ max. Frequency: 40 kHz max. Washing time: 5 minutes max.</p> <p>2.3 If the cleaning fluid is contaminated, the Halogen concentration can increases and it may bring the same result as insufficient cleaning.</p>

(12. Caution, continued)

No.	Process	Condition						
7	Coating and molding of the P.C. Board	<ol style="list-style-type: none"> When the P.C. board is coated, please verify the impact on the capacitor. Please carefully verify that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitor. Please verify the curing temperature. 						
8	Handling after chip mounted	<ol style="list-style-type: none"> Please pay attention not to bend or distort the P.C. board after soldering otherwise the chip capacitor may crack. <div style="text-align: center; margin: 10px 0;">  </div> When functional check of the P.C. board is performed, high pin pressure tends used for fear of loose contact. But if the pressure is excessive and bends the P.C. board, it may crack the chip capacitor or peel the termination. Please adjust the pins accordingly to ensure the P.C. board is not flexed. <table border="1" style="width: 100%; margin-top: 10px;"> <thead> <tr> <th data-bbox="527 1092 657 1144">Item</th> <th data-bbox="657 1092 1047 1144">Not recommended</th> <th data-bbox="1047 1092 1421 1144">Recommended</th> </tr> </thead> <tbody> <tr> <td data-bbox="527 1144 657 1428" style="text-align: center; vertical-align: middle;">Board bending</td> <td data-bbox="657 1144 1047 1428" style="text-align: center;">  </td> <td data-bbox="1047 1144 1421 1428" style="text-align: center;">  </td> </tr> </tbody> </table> 	Item	Not recommended	Recommended	Board bending		
Item	Not recommended	Recommended						
Board bending								

(12. Caution, continued)

No.	Process	Condition
9	Handling of loose chip capacitors	<p>1. The chip capacitor may crack if dropped, especially large case sizes. Please handle with care and do not use if dropped.</p>  <p>Floor</p> <p>Crack</p> <p>2. When stacking the P.C. board for storage or handling after soldering, the corner of the P.C. board may hit the chip capacitor of neighboring board to cause a crack.</p>  <p>Crack</p> <p>P.C. Board</p>
10	Capacitance aging	Class 2 capacitors have aging characteristic, which is a decrease in capacitance over time due to crystalline changes that occur in ferroelectric ceramics. Careful consideration should be done in case of a time constant circuit.
11	Estimated life and estimated failure rate of capacitors	The estimated life and (failure rate) depend on the temperature and voltage applied. This can be calculated by the equation described in JEITA RCR-2335B Annex 6 "Calculation of the estimated lifetime and failure rate". The risk can be decreased by reducing the temperature and the voltage but it will not be guaranteed.
12	Others	<p>The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition.</p> <p>The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that TDK is not responsible for any damage or liability caused by use of this product in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet:</p> <p>Aerospace/Aviation equipment. Transportation equipment (cars, electric trains, ships, etc.) Medical equipment. Power-generation control equipment. Atomic energy-related equipment. Seabed equipment. Transportation control equipment. Public information-processing equipment. Military equipment. Electric heating apparatus, burning equipment. Disaster prevention/crime prevention equipment.</p> <p>Safety equipment. Other applications that are not considered general-purpose applications.</p> <p>When using this product in general-purpose applications, you are kindly requested to take into consideration securing protection circuit/equipment or providing backup circuits, etc., to ensure higher safety.</p>

13. Packaging label

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 1) Inspection No.
- 2) TDK P/N
- 3) Customer's P/N
- 4) Quantity

*Composition of Inspection No.

Example M 0 A - 00 - 000
 (a) (b) (c) (d) (e)

- a) Line code
- b) Last digit of the year
- c) Month and A for January and B for February and so on. (Skip I)
- d) Inspection Date of the month.
- e) Serial No. of the day

14. Bulk packaging quantity

Total number of components in a plastic bag for bulk packaging: 1,000pcs.
As for C1005 type, not available for bulk packaging.

15. TAPE PACKAGING SPECIFICATION

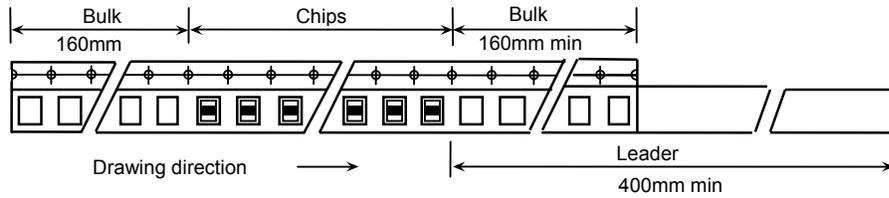
1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3, 4.

Dimensions of plastic tape shall be according to Appendix 5, 6.

1-2. Bulk part and leader of taping

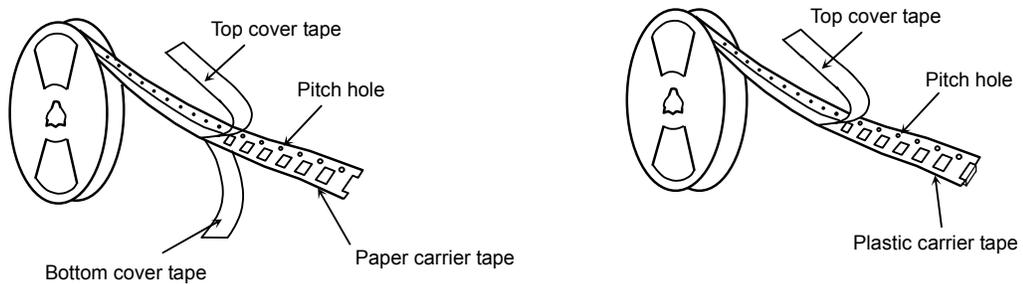


1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 7, 8.

Dimensions of Ø330 reel shall be according to Appendix 9, 10.

1-4. Structure of taping



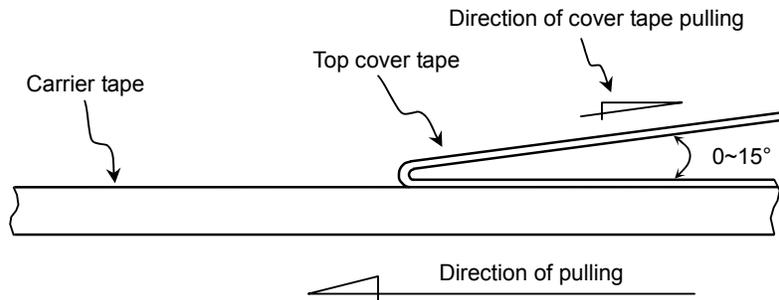
2. CHIP QUANTITY

Type	Thickness of chip	Taping Material	Chip quantity (pcs.)	
			φ178mm reel	φ330mm reel
C1005	0.50 mm	Paper	10,000	50,000
C1608	0.80 mm	Paper	4,000	10,000
C2012	0.60 mm	Paper *Plastic	4,000	20,000
	0.85 mm			10,000
	1.25 mm	Plastic	2,000	
C3216	0.60 mm	Paper	4,000	10,000
	0.85 mm	Paper *Plastic		
	1.15 mm	Plastic	2,000	
	1.30 mm			
	1.60 mm			
C3225	1.15 mm	Plastic	2,000	10,000
	1.25 mm		2,000	8,000
	1.30 mm			
	1.60 mm		1,000	5,000
	2.00 mm			
	2.30 mm			
	2.50 mm			
C4532	1.60 mm	Plastic	1,000	3,000
	2.00 mm			
	2.30 mm		500	
	2.50 mm			
	2.80 mm			2,000
	3.20 mm			
C5750	1.60 mm	Plastic	1,000	3,000
	2.00 mm		500	
	2.30 mm			
	2.50 mm			
	2.80 mm			2,000

3. PERFORMANCE SPECIFICATIONS

3.1 Peel back cover (top tape)

0.05-0.7N. (See the following figure.)



3.2 Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.

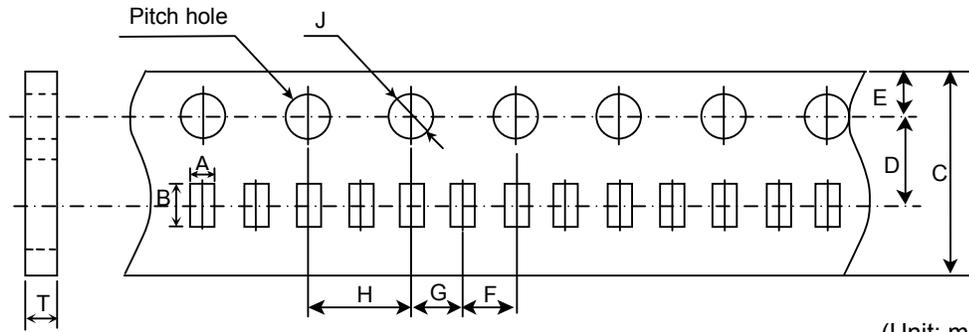
3.3 The missing of components shall be less than 0.1%

3.4 Components shall not stick to the cover tape.

3.5 The cover tapes shall not protrude beyond the edges of the carrier tape not shall cover the sprocket holes.

Appendix 3

Paper Tape



(Unit: mm)

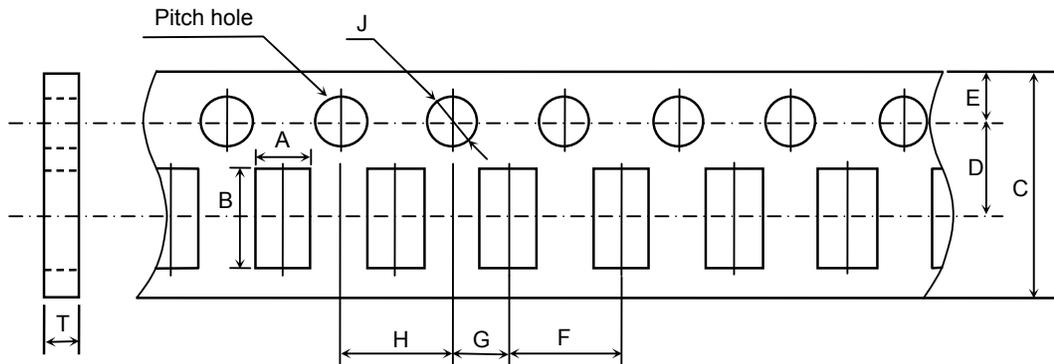
Symbol Type	A	B	C	D	E	F
C1005 (CC0402)	(0.65)	(1.15)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	2.00 ± 0.05

Symbol Type	G	H	J	T
C1005 (CC0402)	2.00 ± 0.05	4.00 ± 0.10	$\varnothing 1.5 \begin{smallmatrix} +0.10 \\ 0 \end{smallmatrix}$	0.60 ± 0.05

* The values in the parentheses () are for reference

Appendix 4

Paper Tape



(Unit: mm)

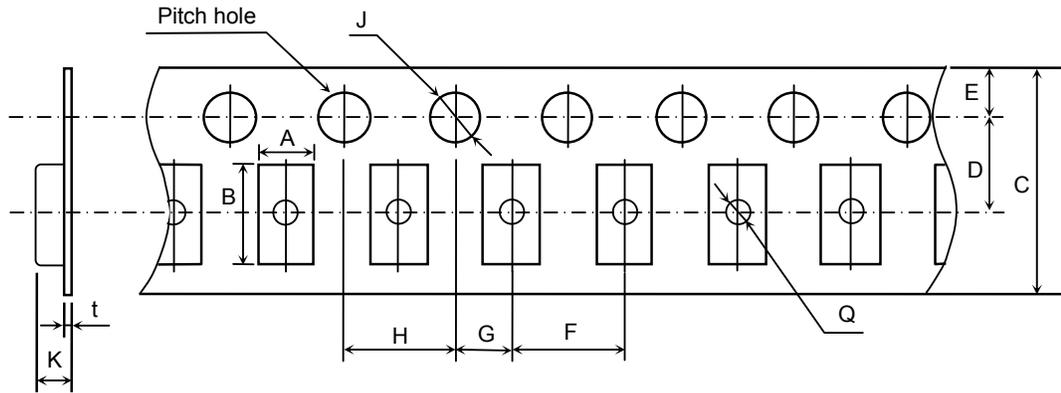
Symbol Type	A	B	C	D	E	F
C1608 (CC0603)	(1.10)	(1.90)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
C2012 (CC0805)	(1.50)	(2.30)				
C3216 (CC1206)	(1.90)	(3.50)				

Symbol Type	G	H	J	T
C1608 (CC0603)	2.00 ± 0.05	4.00 ± 0.10	$\varnothing 1.5 \begin{smallmatrix} +0.10 \\ 0 \end{smallmatrix}$	1.10 max.
C2012 (CC0805)				
C3216 (CC1206)				

* The values in the parentheses () are for reference.

Appendix 5

Plastic Tape



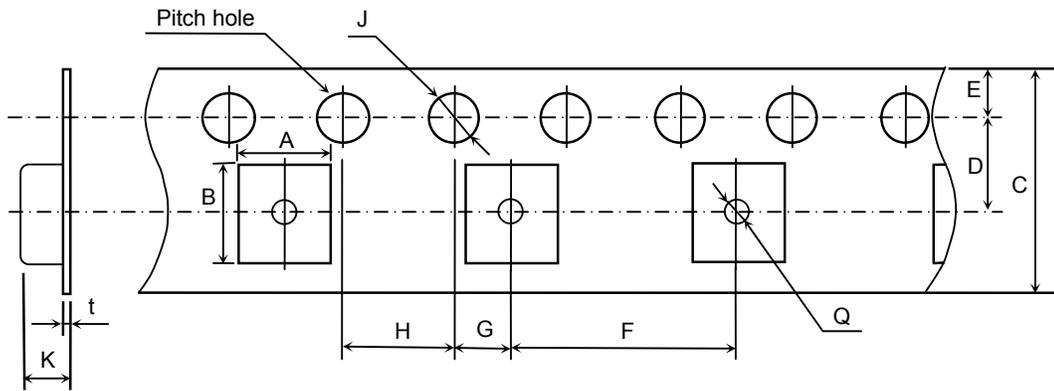
(Unit: mm)

Symbol Type	A	B	C	D	E	F
C2012 (CC0805)	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
C3216 (CC1206)	(1.90)	(3.50)				
C3225 (CC1210)	(2.90)	(3.60)				
Symbol Type	G	H	J	K	t	Q
C2012 (CC0805)	2.00 ± 0.05	4.00 ± 0.10	∅ 1.5 ^{+0.10} ₀	2.50 max.	0.30 max.	∅ 0.50 min.
C3216 (CC1206)				3.20 max.	0.60 max.	
C3225 (CC1210)						

* The values in the parentheses () are for reference.

Appendix 6

Plastic Tape



(Unit: mm)

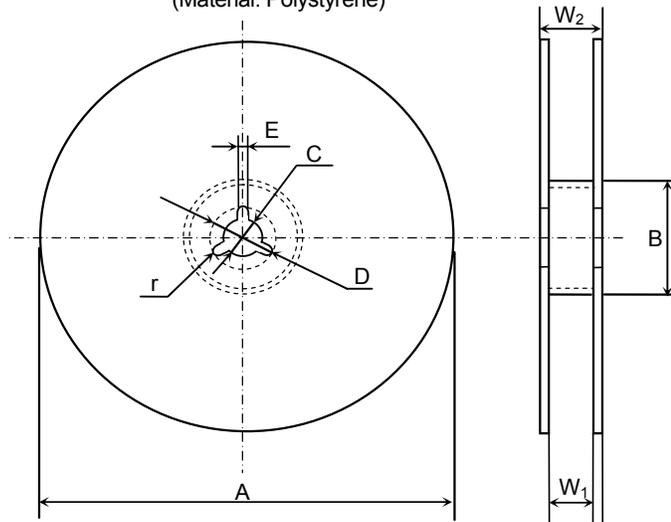
Symbol Type	A	B	C	D	E	F
C4532 (CC1812)	(3.60)	(4.90)	12.0 ± 0.30	5.50 ± 0.05	1.75 ± 0.10	8.00 ± 0.10
C5750 (CC2220)	(5.40)	(6.10)				
Symbol Type	G	H	J	K	t	Q
C4532 (CC1812)	2.00 ± 0.05	4.00 ± 0.10	∅ 1.5 ^{+0.10} ₀	6.50 max.	0.60 max.	∅ 1.50 min.
C5750 (CC2220)						

* The values in the parentheses () are for reference.

Appendix 7

C1005, C1608, C2012, C3216, C3225

(Material: Polystyrene)



(Unit: mm)

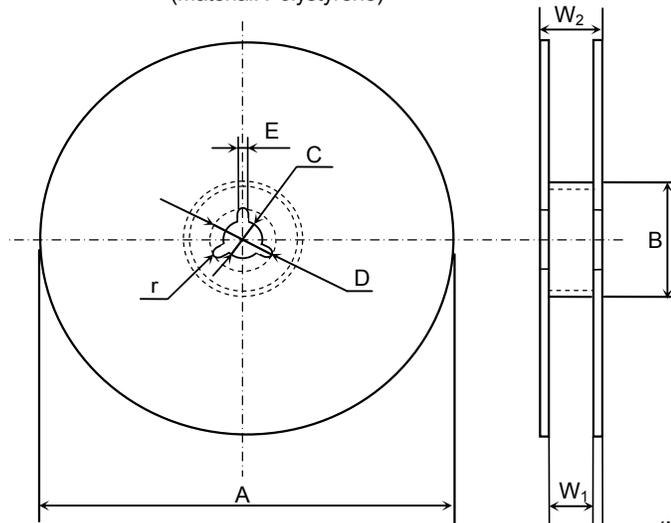
Symbol	A	B	C	D	E	W ₁
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3

Symbol	W ₂	r
Dimension	13.0 ± 1.4	1.0

Appendix 8

C4532, C5750

(Material: Polystyrene)



(Unit: mm)

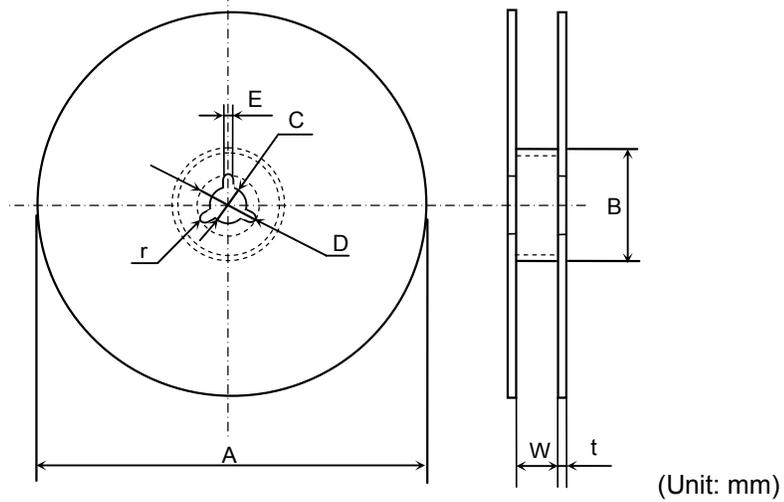
Symbol	A	B	C	D	E	W ₁
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	13.0 ± 0.3

Symbol	W ₂	r
Dimension	17.0 ± 1.4	1.0

Appendix 9

C1005, C1608, C2012, C3216, C3225

(Material: Polystyrene)



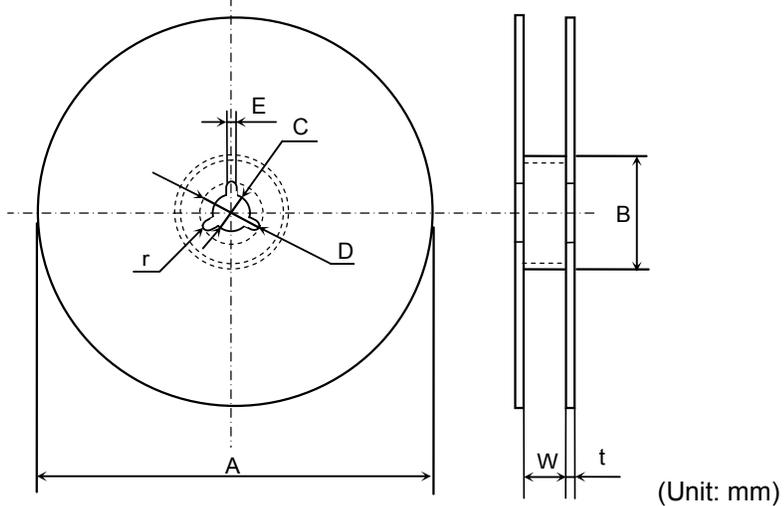
Symbol	A	B	C	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	10.0 ± 1.5

Symbol	t	r
Dimension	2.0 ± 0.5	1.0

Appendix 10

C4532, C5750

(Material: Polystyrene)



Symbol	A	B	C	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	14.0 ± 1.5

Symbol	t	r
Dimension	2.0 ± 0.5	1.0

END PAGE